Se	Search Notes		

Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/790,723	LEE ET AL.	
	Examiner	Art Unit	
	Fetsum Abraham	2826	

SEARCHED			
	, JEAN		
Class	Subclass	Date	Examiner
257	678 684 690 693 698 704	5/5/2005	FA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			1

SE (INCLUDINC	ARCH NOTES SEARCH STRAT	EGY)
	DAT	
WEST	6/5/20	005 FA
 		